### Deposition of Alkanethiolate Self-Assembled Monolayers on Germanium

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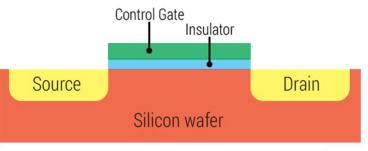


## Motivation and Background

- <u>Problem</u>: Ge form unstable oxides that inhibit device performance.
  - Need to find effective surface passivation method for Ge at reasonable time scales
  - Passivation layer = coat of protective material that reduces the amount of chemical reactivity on the surface

Material	Hole Mobility (cm <sup>2</sup> V/s)
Silicon	200
Germanium	450

Del Alamo, Jesús A. "Nanometre-scale electronics with III-V compound semiconductors." *Nature* 479.7373 (2011): 317-323.



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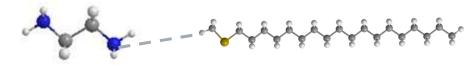
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# Motivation and Background

• Use octadecanethiol (ODT) as passivation reagent.



EDA converts thiol to thiolate.

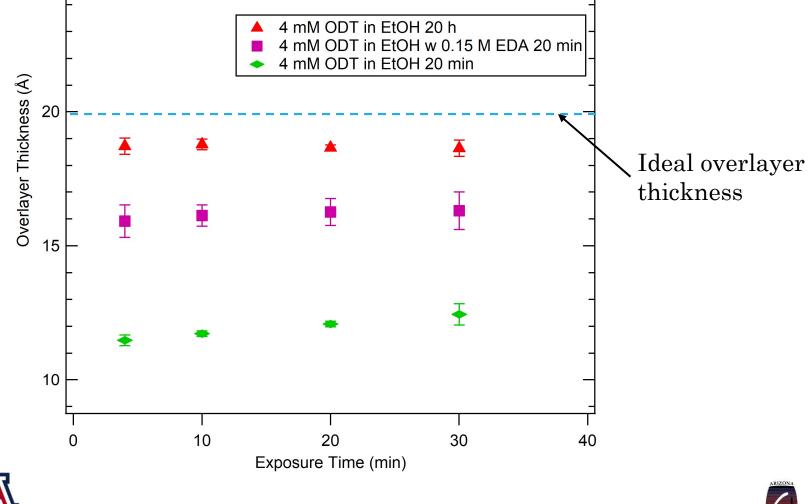
- Long-chain thiol
- Used successfully in literature, but at long time scales (20 h)
  - Not practical for industry
- **Goal:** reduce passivation time by adding ethylenediamine (EDA)

Ge





# Adding amine increases layer thickness

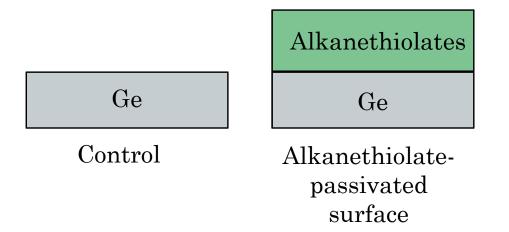






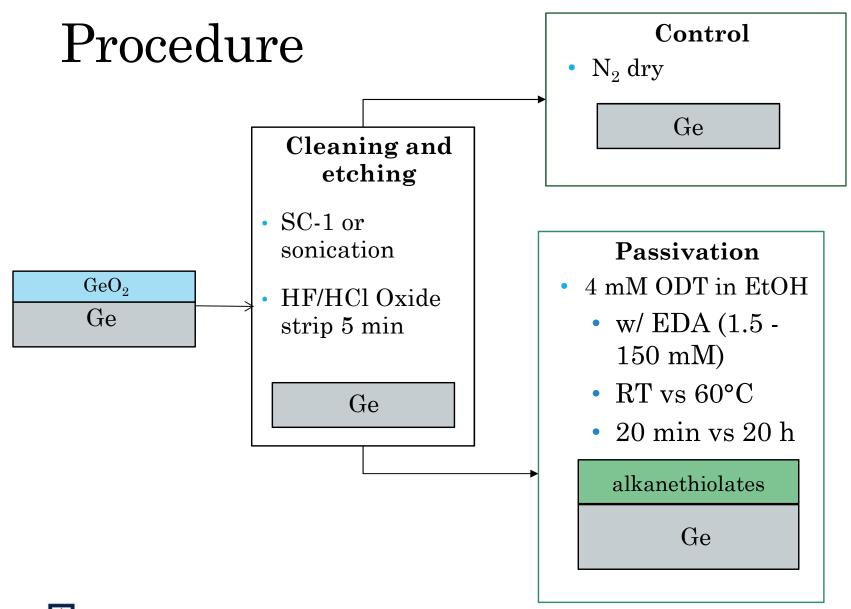
# Objective

• Goal: Reduce the deposition time of a dense, highly-ordered alkanethiolate passivation.













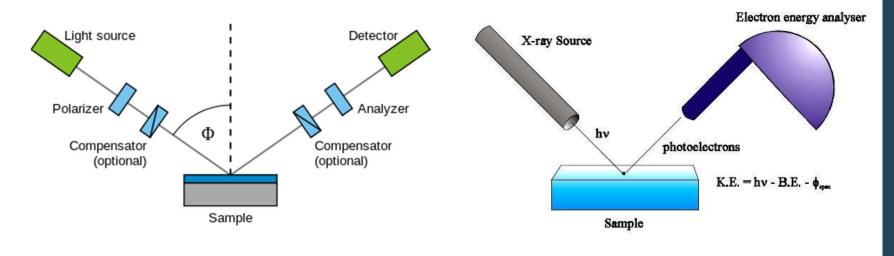
### Characterization

Spectroscopic ellipsometry

• Measured overlayer (oxides) thickness

#### X-ray photoelectron spectroscopy (XPS)

• Determine chemical species on surface.



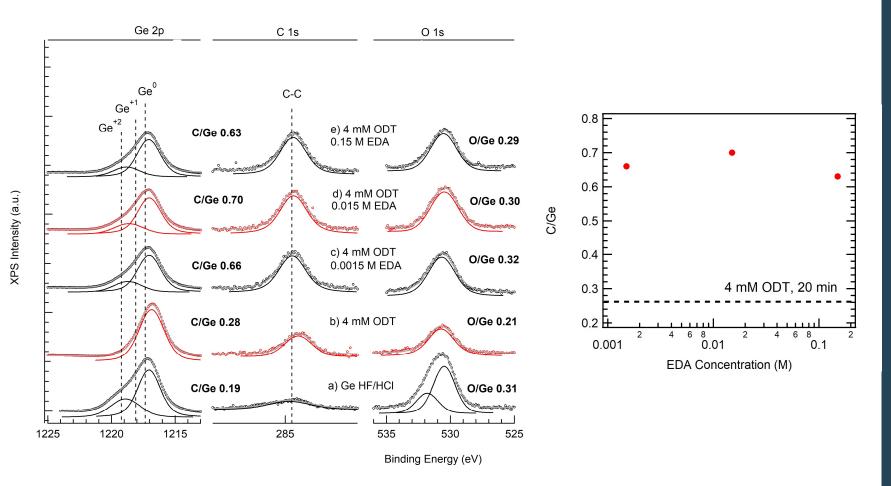
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#### Amine increases carbon coverage



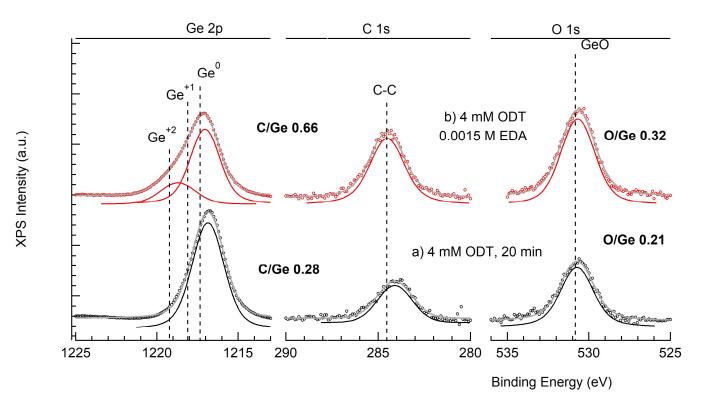
- Amine does not oxidize the surface.
- Concentration of amine does not affect coverage



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# For 20 h immersion, amine decreases C/Ge ratio

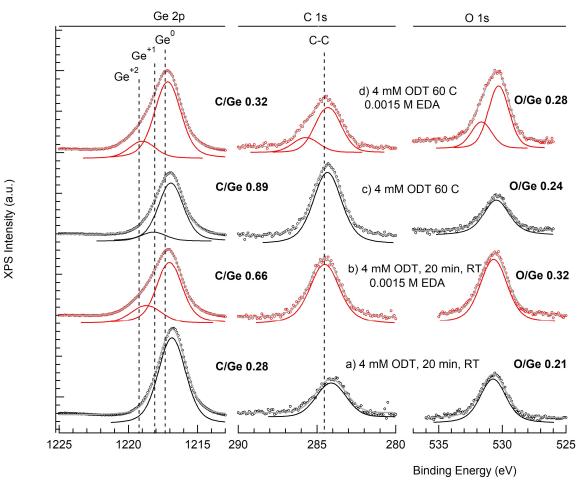


• At 20 h, thiol and amine solutions show a decrease in the C/Ge ratio than just thiol alone.





# Increasing temperature with amine decreases C/Ge ratio

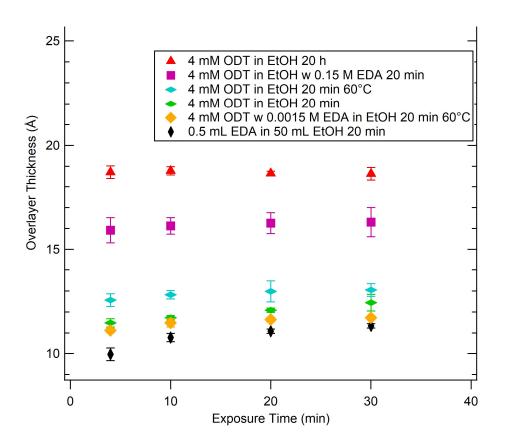


• Increasing temperature increase C/Ge ratio for thiol alone, but decreases C/Ge ratio for thiol and amine solutions.





# Overlayer thickness corroborates XPS results



- With EDA, increasing T
  → Lower thickness
- At 60°C, adding EDA
  → Lower thickness
- At RT, adding EDA → higher thickness
- ODT alone, increasing T  $\rightarrow$  higher thickness





### Conclusions

- EDA helps at RT and does not contribute to oxidation.
- 20 h immersion produces a more dense and highly-ordered layer than 20 min immersion
- Increasing temperature for solutions with EDA does not produce a more dense and highly-ordered layer.

#### Future Work

• Confirm temperature trends.



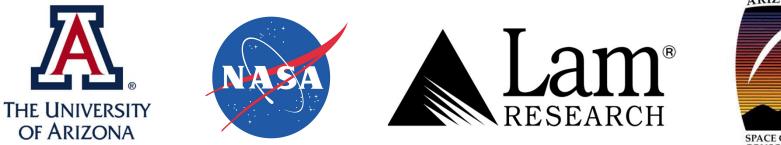


## Acknowledgements

Muscat Research Group

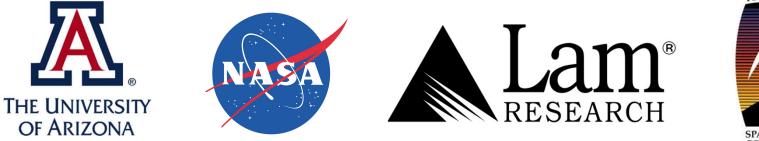
#### NASA/Arizona Space Grant Consortium

Lam Research





# Thank you!





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